

# SANYO Semiconductors DATA SHEET

## 2SJ630-

P-Channel Silicon MOSFET

### General-Purpose Switching Device Applications

#### **Features**

- · Low ON-resistance.
- · Ultrahigh-speed switching.
- 1.8V drive.

#### **Specifications**

#### Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		-12	V
Gate-to-Source Voltage	VGSS		±8	V
Drain Current (DC)	ID		-6	Α
Drain Current (Pulse)	IDP	PW≤10μs, duty cycle≤1%	-24	Α
Allowable Power Dissipation	PD	Mounted on a ceramic board (600mm <sup>2</sup> X0.8mm)	1.5	W
		Tc=25°C	3.5	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

#### Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Uill
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=-1mA, VGS=0V	-12			V
Zero-Gate Voltage Drain Current	IDSS	V <sub>DS</sub> =-12V, V <sub>GS</sub> =0V			-10	μΑ
Gate-to-Source Leakage Current	IGSS	V <sub>GS</sub> =±6.4V, V <sub>DS</sub> =0V			±10	μΑ
Cutoff Voltage	VGS(off)	VDS=-6V, ID=-1mA	-0.3		-1.0	V
Forward Transfer Admittance	yfs	V <sub>DS</sub> =-6V, I <sub>D</sub> =-3A	5.7	9.5		S
Static Drain-to-Source On-State Resistance	R <sub>DS</sub> (on)1	I <sub>D</sub> =-3A, V <sub>G</sub> S=-4.5V		45	58	mΩ
	RDS(on)2	ID=-1.5A, VGS=-2.5V		57	80	mΩ
	R <sub>DS</sub> (on)3	I <sub>D</sub> =-0.3A, V <sub>G</sub> S=-1.8V		78	112	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> =-6V, f=1MHz		940		pF
Output Capacitance	Coss	V <sub>DS</sub> =-6V, f=1MHz		230		pF
Reverse Transfer Capacitance	Crss	V <sub>DS</sub> =-6V, f=1MHz		180		pF
Turn-ON Delay Time	t <sub>d</sub> (on)	See specified Test Circuit.		12		ns
Rise Time	t <sub>r</sub>	See specified Test Circuit.		143		ns
Turn-OFF Delay Time	t <sub>d</sub> (off)	See specified Test Circuit.		71		ns
Fall Time	t <sub>f</sub>	See specified Test Circuit.		89		ns

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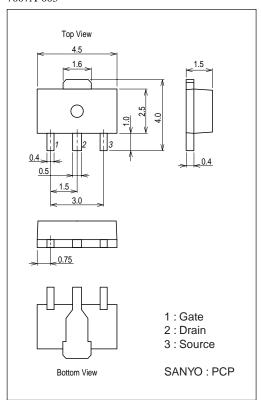
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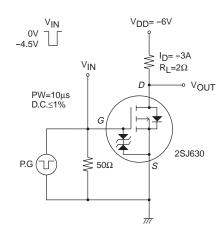
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Total Gate Charge	Qg	V <sub>DS</sub> =-6V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-6A		11		nC
Gate-to-Source Charge	Qgs	V <sub>DS</sub> =-6V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-6A		1.6		nC
Gate-to-Drain "Miller" Charge	Qgd	V <sub>DS</sub> =-6V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-6A		2.8		nC
Diode Forward Voltage	VSD	IS=-6A, VGS=0V		-0.95	-1.5	V

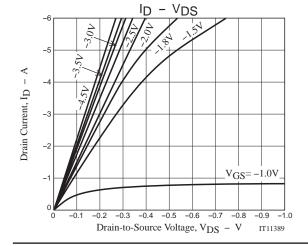
#### **Package Dimensions**

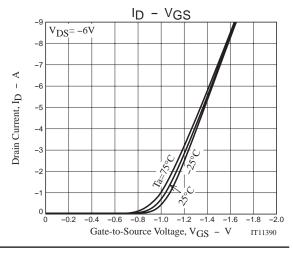
unit : mm (typ) 7007A-003

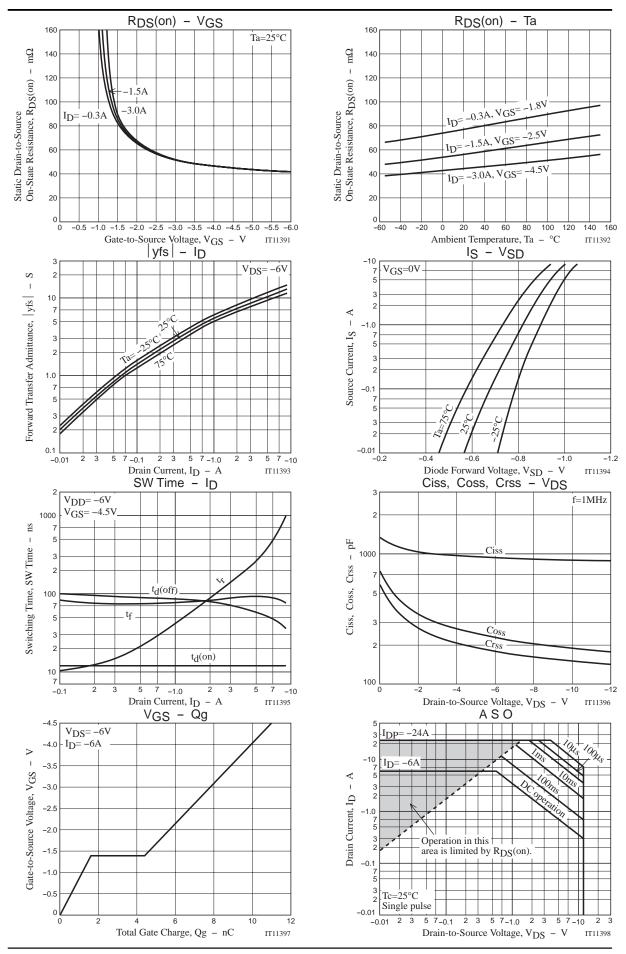


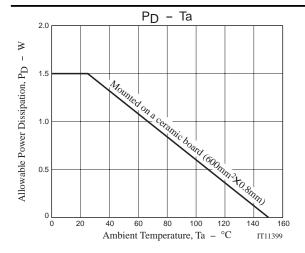
#### **Switching Time Test Circuit**

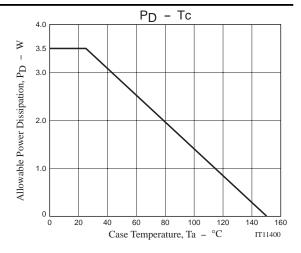












Note on usage: Since the 2SJ630 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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